

# Choong Hee Lee

## List of Publications by Year in descending order

Source: <https://exaly.com/author-pdf/2819510/publications.pdf>

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13  
papers

1,172  
citations

933447

10  
h-index

1281871

11  
g-index

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all docs

13  
docs citations

13  
times ranked

2604  
citing authors

#	ARTICLE	IF	CITATIONS
1	Room Temperature Intrinsic Ferromagnetism in Epitaxial Manganese Selenide Films in the Monolayer Limit. Nano Letters, 2018, 18, 3125-3131.	9.1	567
2	p-type doping of MoS <sub>2</sub> thin films using Nb. Applied Physics Letters, 2014, 104, 092104.	3.3	268
3	Layer-transferred MoS <sub>2</sub> /GaN PN diodes. Applied Physics Letters, 2015, 107, .	3.3	69
4	High current density 2D/3D MoS <sub>2</sub> /GaN Esaki tunnel diodes. Applied Physics Letters, 2016, 109, .	3.3	65
5	Epitaxial growth of large area single-crystalline few-layer MoS <sub>2</sub> with high space charge mobility of $192 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ . Applied Physics Letters, 2014, 105, .	3.3	57
6	Molecular beam epitaxy of 2D-layered gallium selenide on GaN substrates. Journal of Applied Physics, 2017, 121, .	2.5	52
7	Growth and electrical characterization of two-dimensional layered MoS <sub>2</sub> /SiC heterojunctions. Applied Physics Letters, 2014, 105, .	3.3	42
8	Transferred large area single crystal MoS <sub>2</sub> field effect transistors. Applied Physics Letters, 2015, 107, .	3.3	21
9	BaTiO <sub>3</sub> /Al <sub>0.58</sub> Ga <sub>0.42</sub> N lateral heterojunction diodes with breakdown field exceeding 8 MV/cm. Applied Physics Letters, 2020, 116, .	3.3	17
10	Large-area SnSe <sub>2</sub> /GaN heterojunction diodes grown by molecular beam epitaxy. Applied Physics Letters, 2017, 111, .	3.3	11
11	Molecular beam epitaxy of GaN on 2H-MoS <sub>2</sub> . Applied Physics Letters, 2020, 117, .	3.3	3
12	Exploring Thermal Properties of MoS <sub>2</sub> Using In Situ Quantitative STEM. Microscopy and Microanalysis, 2016, 22, 912-913.	0.4	0
13	Atomic Scale Structure and Defects in 2D GaSe Films and Van der Waals Interface. Microscopy and Microanalysis, 2017, 23, 1728-1729.	0.4	0